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U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE

LIST OF REFERENCES CITED BY APPLICANT

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Sheet 1 of 1

APPLICATION NO.

1293.1817

FIRST NAMED INVENTOR

Kwang KIM et al.

FILING DATE

July 8, 2003

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Sheet 1 of 1 10/614,701

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FIRST NAMED INVENTOR Kwang KIM et al. FILING DATE GROUP ART UNIT 2873 July 8, 2003

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